


<b>Search Notes</b>  	<b>Application/Control No.</b>  10775668	<b>Applicant(s)/Patent Under Reexamination</b>  MACK ET AL.
	<b>Examiner</b>  Tayong, Helene	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	130, 140,141,146,142,147,150,505	1/30/07	HT
332	112	11/14/07	HT
370	213,318,330,335,345	11/14/07	HT
342	15,193	11/14/07	HT

SEARCH NOTES		
Search Notes	Date	Examiner
US_PGPUB, USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM-TDB	1/29/07	Helene Tayong
GOOGLE	1/29/07	Helene Tayong
EAST	1/29/07	Helene Tayong
IEEE EXPLORER	1/29/07	Helene Tayong
Consult with Search Assistant in 2609	1/29/07	Helene Tayong
EAST	5/30/07	Helene tayong
Consulted with SPE (David Payne)	5/30/07	Helene tayong
Consulted with SPE (Shuwang Liu)	11/15/07	HT
NPL	11/15/07	HT
Inventor Name search	1/28/08	HT
Consulted with SPE (Shuwang Liu)	3/17/09	HT
consulted with spe (shuwang Liu)	3/8/10	HT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as above	Same as above	11/15/07	HT
Same as above	Same as above	1/28/08	HT
Same as above	Same as above	3/18/09	HT
same as above	same as above	3/8/10	HT

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